

N-Channel Dual CoolTM 56 Power Trench[®] MOSFET 40 V, 192 A, 1.1 m Ω

Features

- Max $r_{DS(on)}$ = 1.1 m Ω at V_{GS} = 10 V, I_D = 44 A
- Max $r_{DS(on)}$ = 1.5 m Ω at V_{GS} = 4.5 V, I_D = 37 A
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

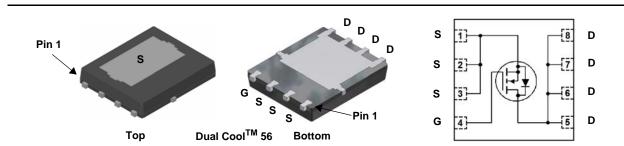


General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench[®] process. Advancements in both silicon and Dual CoolTM package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

Applications

- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion



MOSFET Maximum Ratings T_A = 25 °C unless otherwise noted

Symbol	Parame	ter		Ratings	Units	
V _{DS}	Drain to Source Voltage			40	V	
V _{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T _C = 25 °C		192		
I _D	-Continuous	T _A = 25 °C	(Note 1a)	44	A	
	-Pulsed		(Note 4)	300		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	661	mJ	
р	Power Dissipation	T _C = 25 °C		125	w	
P _D	Power Dissipation	T _A = 25 °C	(Note 1a)	3.2	V	
T _J , T _{STG}	Operating and Storage Junction Temperature Range			-55 to +150	°C	

Thermal Characteristics

$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Top Source)	2.9	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.0	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1b)	81	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
8320L	FDMS8320LDC	Dual Cool [™] 56	13 "	12 mm	3000 units

July 2015

1

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_{D} = 250 \ \mu A, V_{GS} = 0 \ V$	40			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		22		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 32 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	V _{GS} = V _{DS} , I _D = 250 μA	1.0	1.6	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		-6		mV/°C
-		V _{GS} = 10 V, I _D = 44 A		0.8	1.1	
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 4.5 V, I _D = 37 A		1.1	1.5	mΩ
		V_{GS} = 10 V, I_{D} = 44 A, T_{J} = 125 °C		1.2	1.7	
9 _{FS}	Forward Transconductance	$V_{DS} = 5 V, I_{D} = 44 A$		244		S
C _{iss} C _{oss}	Characteristics Input Capacitance Output Capacitance	− V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		8310 2255	11635 3160	pF pF
C _{rss}	Reverse Transfer Capacitance			132	185	pF
R _g	Gate Resistance		0.1	1.4	2.6	Ω
Switching	g Characteristics					
t _{d(on)}	Turn-On Delay Time			19	34	ns
t _r	Rise Time	V _{DD} = 20 V, I _D = 44 A,		15	27	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		69	110	ns
t _f	Fall Time			14	25	ns
Q _{q(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V		121	170	nC
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V} \text{ V}_{DD} = 20 \text{ V},$		57	80	nC
Q _{gs}	Gate to Source Charge	I _D = 44 A		21		nC
Q _{gd}	Gate to Drain "Miller" Charge			16		nC
Drain-Sou	urce Diode Characteristics					
V	Source to Drain Diodo, Earward Valtage	$V_{GS} = 0 V, I_{S} = 2.6 A$ (Note 2)		0.7	1.1	V
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 44 A (Note 2)		0.8	1.2	v
t _{rr}	Reverse Recovery Time	I _F = 44 A, di/dt = 100 A/μs		65	104	ns
Q _{rr}	Reverse Recovery Charge	$F = 44 A, u/ul = 100 A/\mu S$		57	91	nC
t _{rr}	Reverse Recovery Time	- I _F = 44 A, di/dt = 300 A/μs		49	79	ns
Q _{rr}	Reverse Recovery Charge	$\mu_{\rm F} = 44 \Lambda$, ui/ul = 300 $\Lambda/\mu_{\rm S}$	-	89	143	nC

2

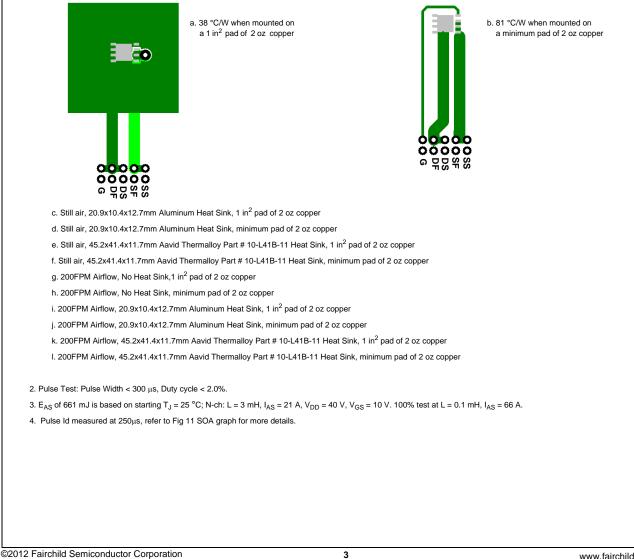
DMS8320LDC	
N-Channel Dual Cool	
Dual (
ower	
56 Power Trench [®]	

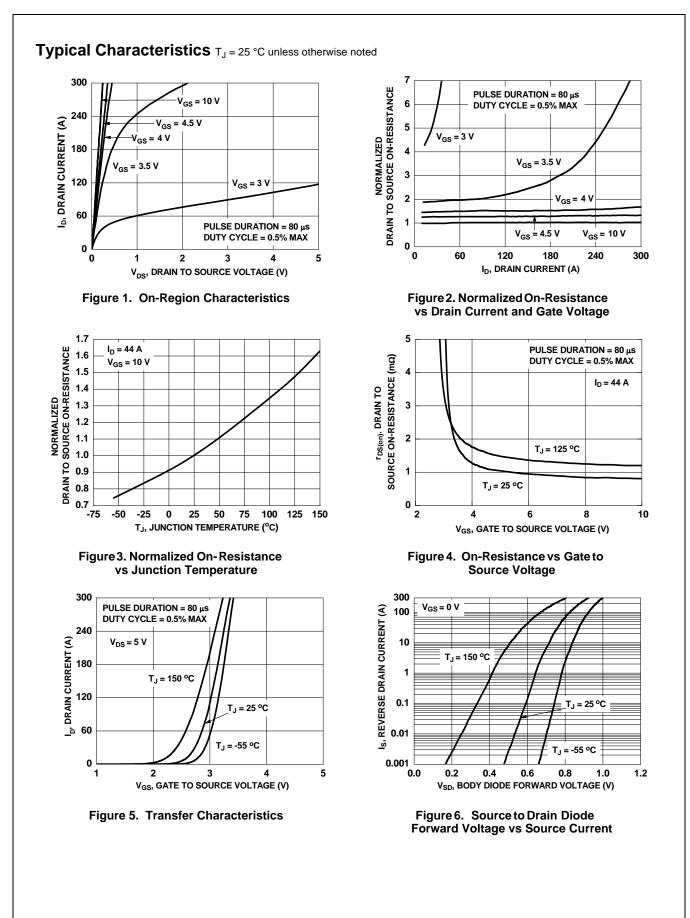
Thermal Characteristics

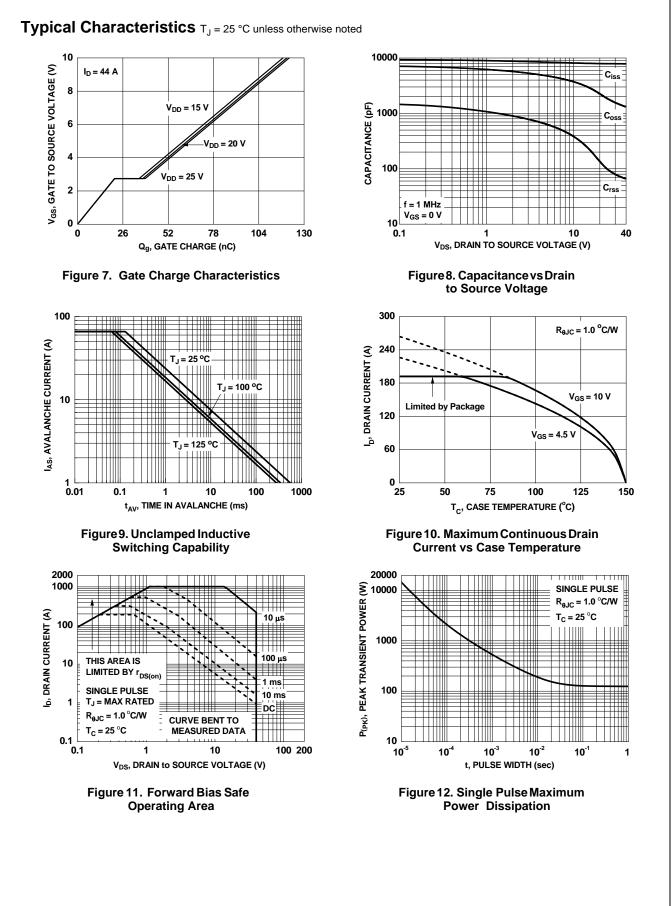
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Top Source)	2.9	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.0	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1e)	16	°C / M
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	19	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	(Note 1k)	11	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

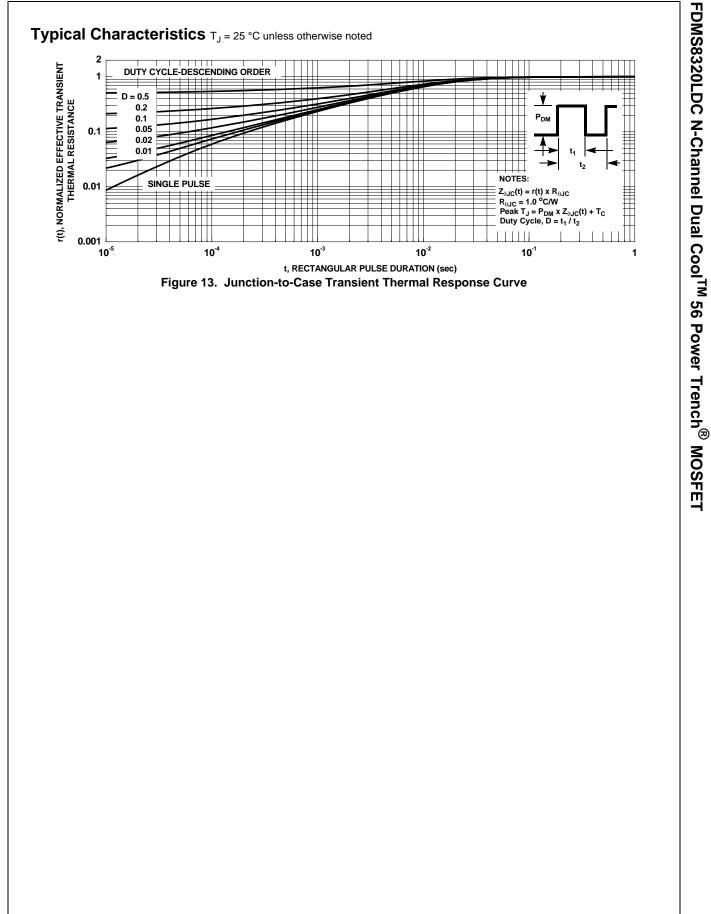
NOTES:

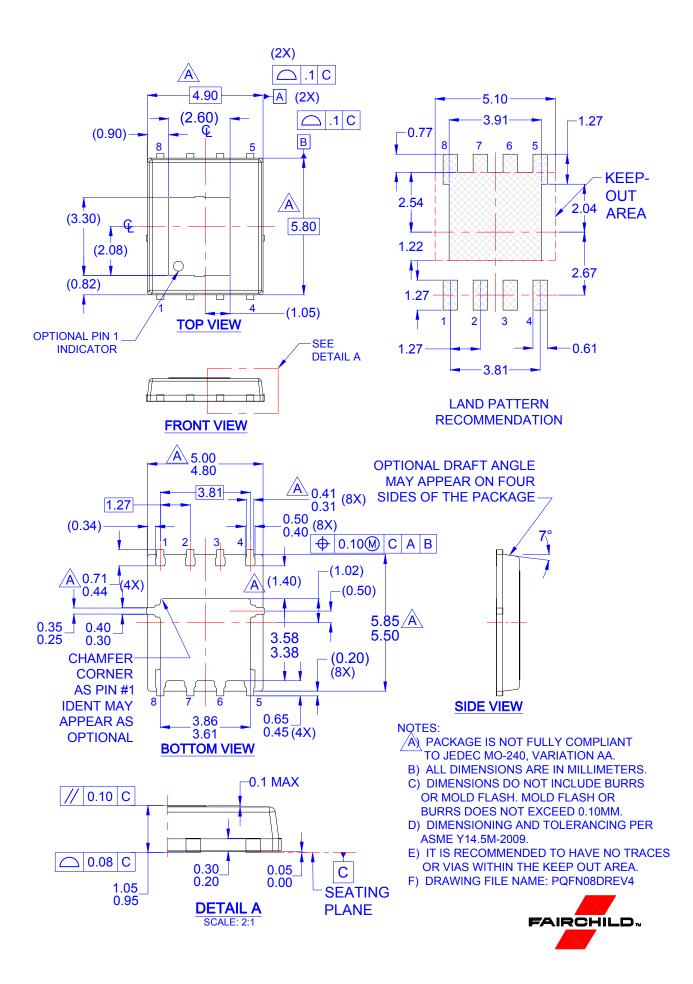
1. R_{0JA} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.













* Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. TO OBTAIN THE LATEST, MOST UP-TO-DATE DATASHEET AND PRODUCT INFORMATION, VISIT OUR WEBSITE AT <u>HTTP://WWW.FAIRCHILDSEMI.COM</u>, FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

AUTHORIZED USE

Unless otherwise specified in this data sheet, this product is a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability. This product may not be used in the following applications, unless specifically approved in writing by a Fairchild officer: (1) automotive or other transportation, (2) military/aerospace, (3) any safety critical application – including life critical medical equipment – where the failure of the Fairchild product reasonably would be expected to result in personal injury, death or property damage. Customer's use of this product is subject to agreement of this Authorized Use policy. In the event of an unauthorized use of Fairchild's product, Fairchild accepts no liability in the event of product failure. In other respects, this product shall be subject to Fairchild's Worldwide Terms and Conditions of Sale, unless a separate agreement has been signed by both Parties.

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com, under Terms of Use

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS

Definition of Terms					
Datasheet Identification Product State		Definition			
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.			
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.			
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.			

Rev. 177

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Fairchild Semiconductor: